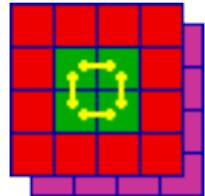


# *MCM Upgrade Status*



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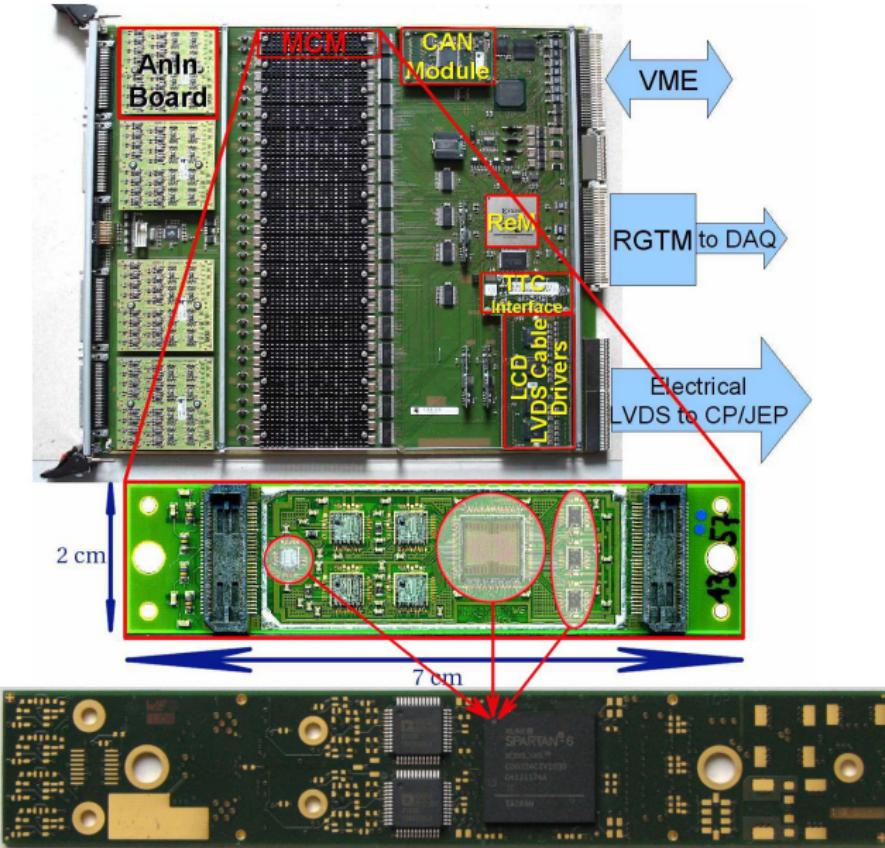


**Level-1 Calorimeter Trigger Joint Meeting**  
Cambridge, 23-25 March 2011

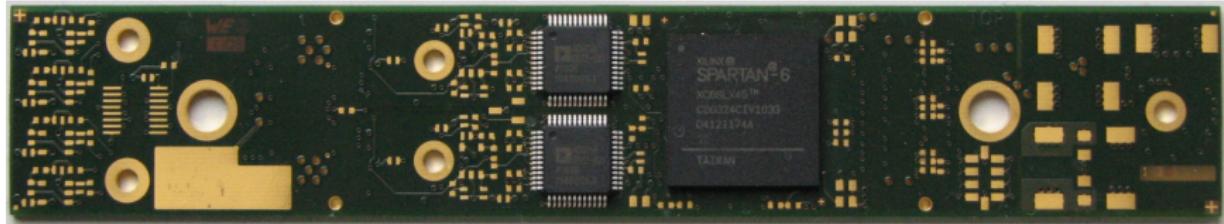
# *Outline*

- 1 PREPROCESSOR MODULE
- 2 NMCM FIRST PROTOTYPE
- 3 EARLY IDEAS FOR THE ADDITIONAL FUNCTIONALITY
  - Test signal generation
  - DC Offset Subtraction
- 4 SCHEDULE

# PreProcessor Module and the New MCM

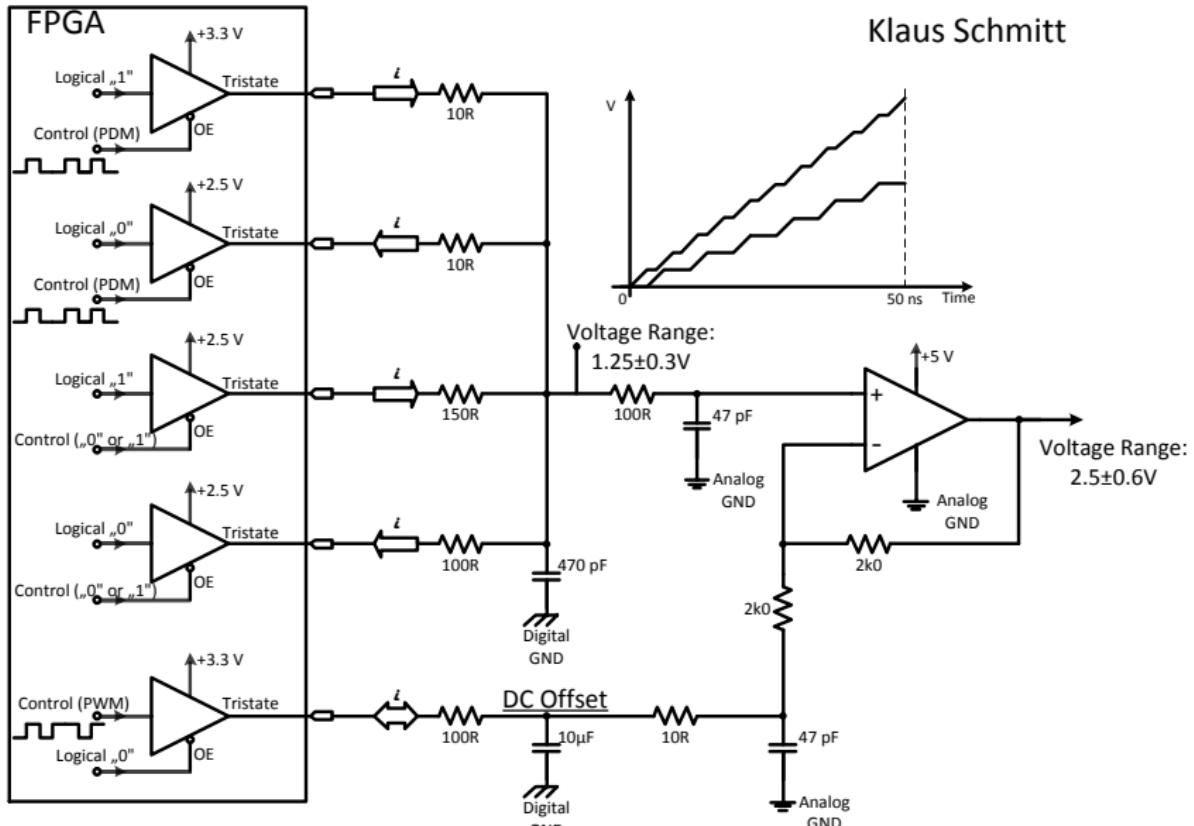


## *Selected nMCM Components*



- AD9218 – dual 105MHz 10bit FADC (running at 80MHz)
- ADA4939-2 OpAmp's (Single-ended-to-differential conversion)
- Xilinx Spartan-6 (SC6SLX45) FPGA in the CSG324 (15x15) package
- Numonyx M25P16 Serial Flash Memory (for the FPGA configuration bitstream and the Module ID)
- LTC3521 DC/DC Converters
- Analogue 1ns delay line

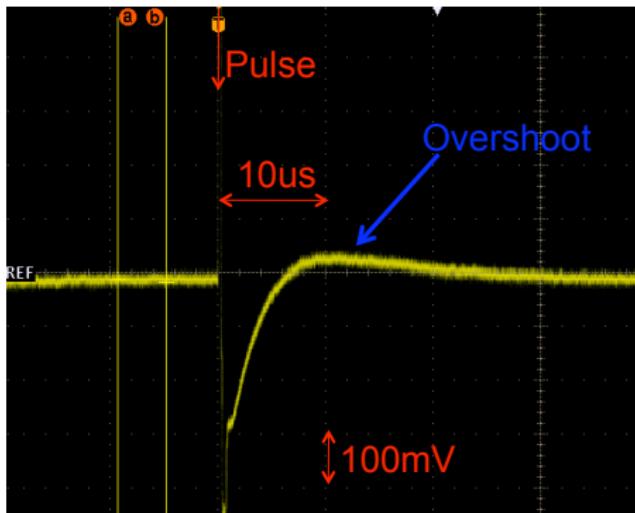
# Test Signal Generation



Monica Dunford:

## Pulse Shapes at Receivers

- At large charges the increase in the baseline after the undershoot is clear



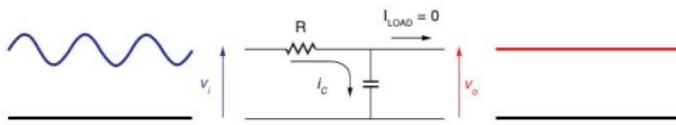
Using the baseline  
before the pulse as a  
reference

At 10us  $\rightarrow \Delta V \sim 40\text{mV}$   
At 30us  $\rightarrow \Delta V \sim 0\text{mV}$

Exists even at the lower  
charges. For 50 pC per  
PMT

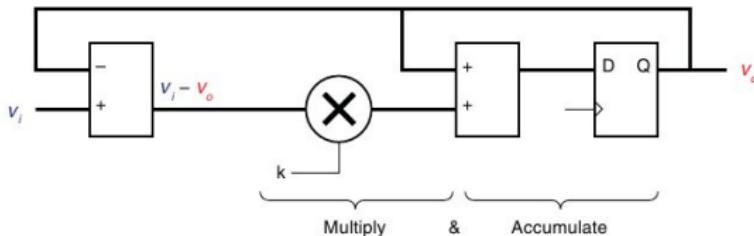
At 10us  $\rightarrow \Delta V \sim 3\text{mV}$   
At 30us  $\rightarrow \Delta V \sim 0\text{mV}$

# DC Offset Subtraction

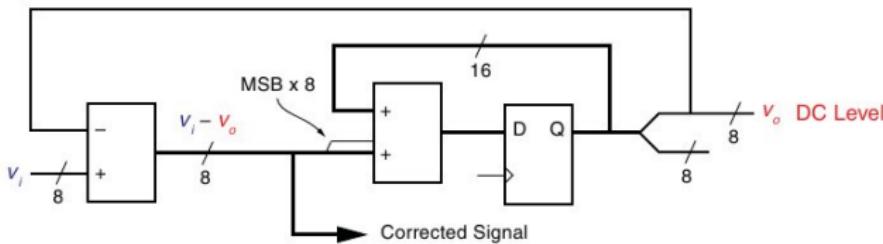


$$k = \frac{\Delta T}{R \times C}$$

$\Delta T$  is defined by the digitisation frequency.  
Digital representation of this circuit is:



or, if  $k = \frac{1}{2^n}$ :



# Schedule

<i>PreProcessor MCM Upgrade</i>		<i>4q_10</i>	<i>1q_11</i>	<i>2q_11</i>	<i>3q_11</i>	<i>4q_11</i>	<i>1q_12</i>	<i>2q_12</i>	<i>3q_12</i>	<i>4q_12</i>
<b>Schematics</b>										
Component selection										
Component purchase for prototypes										
CAD schematics										
<b>PCB Layout</b>										
PCB manuf. for prototypes										
<b>PCB Prototype Production</b>										
Manual PCB loading of prototypes										
Tests of prototypes										
Iterate schem./layout										
<b>MCM Production</b>										
Component purchase for prod.(2048)										
PCB manuf. for prod.(2048)										
PCB loading of prod.(2048)										
Series-Test of prod.(2048)										
Install + Test @USA15 (crate-by-crate)										